PCTEST ENGINEERING LABORATORY, INC.
7185 Oakland Mills Road, Columbia, MD 21045 USA
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MEASUREMENT REPORT
FCC Part 90

Applicant:
Samsung Electronics Co., Ltd.
129, Samsung-ro, Maetan dong,
Yeongtong-gu, Suwon-si
Gyeonggi-do 443-742, Korea

Date of Testing:
4/7/2015
Test Site/Location:
PCTEST Lab., Columbia, MD, USA
Test Report Serial No.:
0Y1504100691.A3L

FCC ID:	**A3L404SC**
APPLICANT:	**SAMSUNG ELECTRONICS CO., LTD.**

Applicant Type:	Certification
FCC Classification:	PCS Licensed Transmitter Held to Ear (PCE)
FCC Rule Part:	§90.691
EUT Type:	Portable Handset
Model(s):	404SC
Test Device Serial No.:	*identical prototype* [S/N:23MAR-3]

Mode	Tx Frequency (MHz)	Emission Designator	Cond. PWR	
			Max. Power (W)	Max. Power (dBm)
LTE Band 26	814.7 - 823.3	1M09G7D	0.210	23.22
LTE Band 26	814.7 - 823.3	1M08W7D	0.177	22.48
LTE Band 26	815.5 - 822.5	2M70G7D	0.205	23.12
LTE Band 26	815.5 - 822.5	2M69W7D	0.175	22.42
LTE Band 26	816.5 - 821.5	4M50G7D	0.207	23.16
LTE Band 26	816.5 - 821.5	4M51W7D	0.181	22.57
LTE Band 26	819	8M99G7D	0.203	23.08
LTE Band 26	819	8M96W7D	0.172	22.36

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in §2.947. Test results reported herein relate only to the item(s) tested.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Randy Ortanez
President

ACCREDITED
TESTING CERT#2041.01

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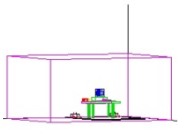
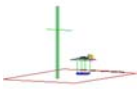


MEASUREMENT REPORT
LTE Band 26



§2.1033 General Information

APPLICANT:	Samsung Electronics Co., Ltd.
APPLICANT ADDRESS:	129, Samsung-ro, Maetan dong, Yeongtong-gu, Suwon-si, Gyeonggi-do 443-742, Korea
TEST SITE:	PCTEST ENGINEERING LABORATORY, INC.
TEST SITE ADDRESS:	7185 Oakland Mills Road, Columbia, MD 21045 USA
BASE MODEL:	404SC
FCC CLASSIFICATION:	PCS Licensed Transmitter Held to Ear (PCE)
MODE:	LTE
FREQUENCY TOLERANCE:	±0.00025 % (2.5 ppm)
Test Device Serial No.:	23MAR-3 ☐ Production ☒ Pre-Production ☐ Engineering
DATE(S) OF TEST:	4/7/2015
TEST REPORT S/N:	0Y1504100691.A3L

Test Facility / Accreditations

Measurements were performed at PCTEST Engineering Lab. located in Columbia, MD 21045, U.S.A.

- PCTEST facility is an FCC registered (PCTEST Reg. No. 159966) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules.
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing Aid Compatibility (HAC) testing, CTIA Test Plans, and wireless testing for FCC.

- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for AMPS, CDMA, and EvDO wireless devices and for Over-the-Air (OTA) Antenna Performance testing for AMPS, CDMA, GSM, GPRS, EGPRS, UMTS (W-CDMA), CDMA 1xEVDO, and CDMA 1xRTT.

1.0 INTRODUCTION

1.1 Scope

Measurement and determination of electromagnetic emissions (EME) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Industry Canada Certification and Engineering Bureau.

1.2 Testing Facility

The map below shows the location of the PCTEST LABORATORY, its proximity to the FCC Laboratory, the Columbia vicinity, the Baltimore-Washington Internt'l (BWI) airport, the city of Baltimore and the Washington, DC area. (*See* **Figure 1-1**).

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility located at 7185 Oakland Mills Road, Columbia, MD 21046. The site coordinates are 39o 10'23" N latitude and 76o 49'50" W longitude. The facility is 0.4 miles North of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4-2003 on February 15, 2012.

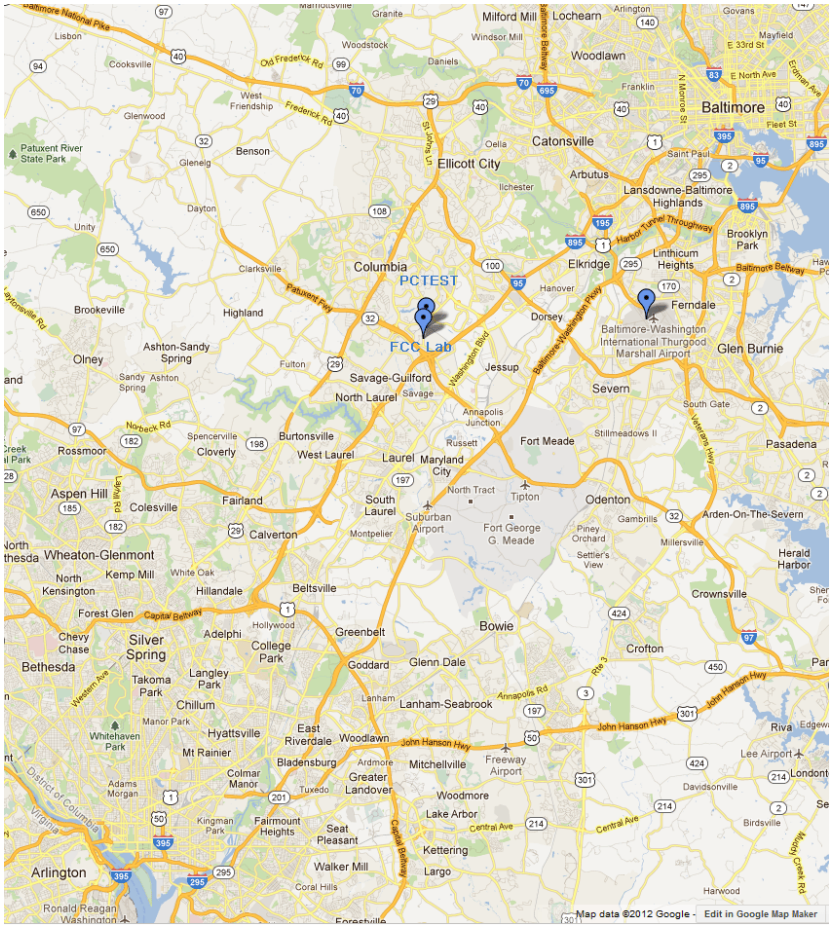


Figure 1-1. Map of the Greater Baltimore and Metropolitan Washington, D.C. area

2.0 PRODUCT INFORMATION

2.1 Equipment Description

The Equipment Under Test (EUT) is the **Samsung Portable Handset FCC ID: A3L404SC**. The EUT consisted of the following component(s):

Trade Name / Base Model	FCC ID	Description
Samsung / Model: 404SC	A3L404SC	Portable Handset

Table 2-1. EUT Equipment Description

Note: All data contained in this report is applicable for the device operation in the LTE Band 26 (814 – 824 MHz). Test data shown supports the devices compliance with §90.691 of the FCC Rules and Regulation.

2.2 Device Capabilities

This device contains the following capabilities:

850/1900 GSM/GPRS/EDGE, 850 WCDMA/HSPA, Multi-band LTE, 802.11b/g/n WLAN, 802.11a/n/ac UNII, Bluetooth (1x, EDR, LE), NFC, ANT+

2.3 Test Configuration

The Samsung Portable Handset FCC ID: A3L404SC was tested per the guidance of ANSI/TIA-603-C-2004 and KDB 971168 v02r02. See Section 6.0 of this test report for a description of the radiated and antenna port conducted emissions tests.

This device supports wireless charging capability and, thus, is subject to the test requirements of KDB 648474 D03 v01r02. Additional radiated spurious emission measurements were performed with the EUT lying flat on a certified wireless charging pad while operating under normal conditions in a simulated call or data transmission configuration. The worst case radiated emissions data is shown in this report.

2.4 EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and no modifications were made during testing.

3.0 DESCRIPTION OF TESTS

3.1 Evaluation Procedure

The measurement procedures described in the "Land Mobile FM or PM – Communications Equipment Measurements and Performance Standards" (ANSI/TIA-603-C-2004) was used in the measurement of the measurement of the **Samsung Portable Handset FCC ID: A3L404SC.**

3.2 Occupied Bandwidth

§2.1049

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The spectrum analyzers' "occupied bandwidth" measurement function was used to record the occupied bandwidth in accordance with KDB 971168.

3.3 Spurious and Harmonic Emissions at Antenna Terminal

§2.1051, §90.691

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10^{th} harmonic.

Out-of-band emission requirement shall apply only to the "outer" channels included in an EA license and to spectrum adjacent to interior channels used by incumbent licensees. The emission limits are as follows:

For any frequency removed from the EA licensee's frequency block by up to and including 37.5 kHz, the power of any emission shall be attenuated below the transmitter power (P) in watts by at least 116 $Log_{10}(f/6.1)$ decibels or 50 + 10 $Log_{10}(P)$ decibels or 80 decibels, whichever is the lesser attenuation, where f is the frequency removed from the center of the outer channel in the block in kilohertz and where f is greater than 12.5 kHz.

For any frequency removed from the EA licensee's frequency block greater than 37.5 kHz, the power of any emission shall be attenuated below the transmitter power (P) in watts by at least 43 + $10Log_{10}(P)$ decibels or 80 decibels, whichever is the lesser attenuation, where f is the frequency removed from the center of the outer channel in the block in kilohertz and where f is greater than 37.5 kHz.

3.4 Radiated Power and Radiated Spurious Emissions

§2.1053, §90.635, §90.691

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. The test site inside the chamber is a 6m x 5.2m elliptical, obstruction-free area in accordance with Clause 5, Figure 5.7 of ANSI C63.4-2009. For measurements above 1GHz absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections. For measurements below 1GHz, the absorbers are removed. An ETS Lindgren Model 2188 raised turntable is used for radiated measurement. It is a continuously rotatable, remote-controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. A 78cm high PVC support structure is placed on top of the turntable. A ¾" (~1.9cm) sheet of high density polyethylene is used as the table top and is placed on top of the PVC supports to bring the total height of the table to 80cm.

The equipment under test was transmitting while connected to its integral antenna and is placed on a wooden turntable 80cm above the ground plane and 3 meters from the receive antenna. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Radiated power levels are also investigated with the receive antenna horizontally and vertically polarized. The maximized power level is recorded using the spectrum analyzer "Channel Power" function with the integration band set to the emissions' occupied bandwidth, a RMS detector, RBW = 100kHz, VBW = 300kHz, and a 1 second sweep time over a minimum of 10 sweeps, per the guidelines of KDB 971168.

Per the guidance of ANSI/TIA-603-C-2004, a half-wave dipole is then substituted in place of the EUT. For emissions above 1GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT. The power of the emission is calculated using the following formula:

$$P_{d\ [dBm]} = P_{g\ [dBm]} - \text{cable loss}_{\ [dB]} + \text{antenna gain}_{\ [dBd/dBi]}$$

Where, P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to $P_{g\ [dBm]}$ – cable loss $_{[dB]}$.

The calculated P_d levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of $43 + 10\log_{10}(\text{Power}_{[Watts]})$ specified in 90.691.

For fundamental radiated power measurements, the guidance of KDB 971168 is used to record the EUT power level that is subsequently matched via the aforementioned substitution method given in ANSI/TIA-603-C-2004.

3.5 Frequency Stability / Temperature Variation

§2.1055, 90.213(a)

Frequency stability testing is performed in accordance with the guidelines of ANSI/TIA-603-C-2004. The frequency stability of the transmitter is measured by:

a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.

b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – For Part 90.213, the frequency stability of the transmitter shall be maintained within ±0.00025% (±2.5 ppm) of the center frequency.

Time Period and Procedure:

1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).

2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.

3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A sufficient stabilization period at each temperature shall be used prior to each frequency requirement.

4.0 TEST EQUIPMENT CALIBRATION DATA

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST).

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
-	LTx1	Licensed Transmitter Cable Set	10/16/2014	Annual	10/16/2015	N/A
-	RE1	Radiated Emissions Cable Set (UHF/EHF)	5/29/2014	Annual	5/29/2015	N/A
Agilent	N9020A	MXA Signal Analyzer	10/27/2014	Annual	10/27/2015	US46470561
Agilent	N9030A	PXA Signal Analyzer (44GHz)	3/17/2015	Annual	3/17/2016	MY52350166
Anritsu	MT8820C	Radio Communication Analyzer	8/28/2014	Annual	8/28/2015	6201240328
Emco	3115	Horn Antenna (1-18GHz)	1/30/2014	Biennial	1/30/2016	9704-5182
ETS Lindgren	3160-09	18-26.5 GHz Standard Gain Horn	6/17/2014	Biennial	6/17/2016	135427
ETS Lindgren	3164-08	Quad Ridge Horn Antenna	3/12/2014	Biennial	3/12/2016	128337
K & L	11SH10-3075/U18000	High Pass Filter	12/1/2014	Annual	12/1/2015	2
K & L	13SH10-1000/U1000	N Type High Pass Filter	12/1/2014	Annual	12/1/2015	1
Mini Circuits	PWR-SEN-4GHS	USB Power Sensor	4/9/2014	Annual	4/9/2015	11401010036
Mini-Circuits	SSG-4000HP	USB Synthesized Signal Generator	N/A			11208010032
Mini-Circuits	TVA-11-422	RF Power Amp	N/A			QA1303002
Rohde & Schwarz	CMW500	Radio Communication Tester	10/4/2013	Biennial	10/4/2015	103962
Rohde & Schwarz	ESU26	EMI Test Receiver (26.5GHz)	3/12/2015	Annual	3/12/2016	100342
Rohde & Schwarz	TS-PR18	1-18 GHz Pre-Amplifier	3/5/2015	Annual	3/5/2016	100071
Rohde & Schwarz	TS-PR26	18-26.5 GHz Pre-Amplifier	3/3/2015	Annual	3/3/2016	100040
Schwarzbeck	UHA 9105	Dipole Antenna (400 - 1GHz) Rx	11/21/2013	Biennial	11/21/2015	9105-2404
Seekonk	NC-100	Torque Wrench 5/16", 8" lbs	3/18/2014	Biennial	3/18/2016	N/A
VWR	62344-734	Thermometer with Clock	2/20/2014	Biennial	2/20/2016	140140420

Table 4-1. Test Equipment

Notes:

1. Equipment with a calibration date of "N/A" shown in this list was not used to make direct calibrated measurements.

5.0 SAMPLE CALCULATIONS

Emission Designator

QPSK Modulation

Emission Designator = 8M62G7D

LTE BW = 8.62 MHz
G = Phase Modulation
7 = Quantized/Digital Info
D = Data transmission, telemetry, telecommand

16QAM Modulation

Emission Designator = 8M45W7D

LTE BW = 8.45 MHz
W = Amplitude/Angle Modulated
7 = Quantized/Digital Info
D = Data transmission, telemetry, telecommand

Spurious Radiated Emission – LTE Band

Example: Middle Channel LTE Mode 2nd Harmonic (1564 MHz)

The average spectrum analzyer reading at 3 meters with the EUT on the turntable was –81.0 dBm. The gain of the substituted antenna is 8.1 dBi. The signal generator connected to the substituted antenna terminals is adjusted to produce a reading of –81.0 dBm on the spectrum analzyer. The loss of the cable between the signal generator and the terminals of the substituted antenna is 2.0 dB at 2453.70 MHz. So 6.1 dB is added to the signal generator reading of –30.9 dBm yielding –24.80 dBm. The fundamental EIRP was 25.501 dBm so this harmonic was 25.501 dBm – (-24.80) = 50.3 dBc.

6.0 TEST RESULTS

6.1 Summary

Company Name: Samsung Electronics Co., Ltd.

FCC ID: A3L404SC

FCC Classification: PCS Licensed Transmitter Held to Ear (PCE)

Mode(s): LTE

Band: Band 26

FCC Part Section(s)	Test Description	Test Limit	Test Condition	Test Result	Reference
§2.1051, §90.691	Band Edge / Conducted Spurious Emissions	> 50 + 10log$_{10}$ (P[Watts]) at Band Edge and for all out-of-band emissions within 37.5kHz of Block Edge	CONDUCTED	PASS	Section 7.0
§2.1046, §90.635	Conducted Power	< 100 Watts		PASS	Section 6.2
§2.1055, §90.213	Frequency Stability	< 2.5 ppm		PASS	Section 6.4
§2.1053, §90.691	Undesirable Emissions	> 43 + 10log$_{10}$ (P[Watts]) for all out-of-band emissions	RADIATED	PASS	Sections 6.3

Table 6-1. Summary of Test Results

Notes:

1) All modes of operation and data rates were investigated. The test results shown in the following sections represent the worst case emissions.
2) The analyzer plots shown in Section 7.0 were taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables, directional couplers, and attenuators used as part of the system to maintain a link between the call box and the EUT at all frequencies of interest.
3) All antenna port conducted emissions testing was performed on a test bench with the antenna port of the EUT connected to the spectrum analyzer through calibrated cables, attenuators, and couplers.

6.2 Conducted Power Output Data

§90.635

Frequency [MHz]	Channel Bandwidth [MHz]	Mod.	Cond. PWR [dBm]	Cond. PWR [Watts]	Cond. PWR Limit [dBm]	Margin [dB]
814.70	1.4	QPSK	23.22	0.210	50.00	-26.78
823.30	1.4	QPSK	23.08	0.203	50.00	-26.92
814.70	1.4	16-QAM	22.48	0.177	50.00	-27.52
823.30	1.4	16-QAM	22.20	0.166	50.00	-27.80
815.50	3	QPSK	23.12	0.205	50.00	-26.88
822.50	3	QPSK	23.02	0.200	50.00	-26.98
815.50	3	16-QAM	22.36	0.172	50.00	-27.64
822.50	3	16-QAM	22.42	0.175	50.00	-27.58
816.50	5	QPSK	23.05	0.202	50.00	-26.95
821.50	5	QPSK	23.16	0.207	50.00	-26.84
816.50	5	16-QAM	22.31	0.170	50.00	-27.69
821.50	5	16-QAM	22.57	0.181	50.00	-27.43
819.00	10	QPSK	23.08	0.203	50.00	-26.92
819.00	10	16-QAM	22.36	0.172	50.00	-27.64

Table 6-2. LTE Band 26 Conducted Power Output Data

NOTES:

1. For LTE mode, the device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported with 1 RB.

2. This unit was tested with its standard battery.

6.3 Radiated Spurious Emissions Measurements

§2.1053, §90.691

Field Strength of SPURIOUS Radiation for LTE Band 26

OPERATING FREQUENCY: 814.70 MHz

CHANNEL: 26697

MODULATION SIGNAL: QPSK

BANDWIDTH: 1.4 MHz

DISTANCE: 3 meters

LIMIT: -13.00 dBm

Frequency [MHz]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBd]	Spurious Emission Level [dBm]	Ant. Pol. [H/V]	Margin [dBm]
1629.40	-59.33	6.60	-52.73	V	-39.7

Table 6-3. Radiated Spurious Data (Ch. 26697)

NOTES:

1. For LTE mode, the device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported with 1 RB.
2. This unit was tested with its standard battery.
3. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The worst case setup is reported in the tables below.

Radiated Spurious Emissions Measurements

§2.1053, §90.691

Field Strength of SPURIOUS Radiation for LTE Band 26

OPERATING FREQUENCY: 823.30 MHz

CHANNEL: 26783

MODULATION SIGNAL: QPSK

BANDWIDTH: 1.4 MHz

DISTANCE: 3 meters

LIMIT: -13.00 dBm

Frequency [MHz]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBd]	Spurious Emission Level [dBm]	Ant. Pol. [H/V]	Margin [dBm]
1646.60	-58.69	6.60	-52.10	V	-39.1

Table 6-4. Radiated Spurious Data (Ch. 26783)

NOTES:

1. For LTE mode, the device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported with 1 RB.
2. This unit was tested with its standard battery.
3. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The worst case setup is reported in the tables below.

Radiated Spurious Emissions Measurements
§2.1053, §90.691

Field Strength of SPURIOUS Radiation for LTE Band 26

OPERATING FREQUENCY:	823.30	MHz
CHANNEL:	26783	
MODULATION SIGNAL:	QPSK	
BANDWIDTH:	1.4	MHz
DISTANCE:	3	meters
LIMIT:	-13.00	dBm

Frequency [MHz]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBd]	Spurious Emission Level [dBm]	Ant. Pol. [H/V]	Margin [dBm]
1646.60	-59.17	6.60	-52.58	H	-39.6

Table 6-5. Radiated Spurious Data with WCP(Ch. 26783)

NOTES:

1. For LTE mode, the device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported with 1 RB.
2. This unit was tested with its standard battery.
3. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The worst case setup is reported in the tables below.

6.4 Frequency Stability / Temperature Variation

§2.1055, §90.213

OPERATING FREQUENCY:	814,700,000	Hz
CHANNEL:	26697	
REFERENCE VOLTAGE:	3.85	VDC
DEVIATION LIMIT:	± 0.00025 % or 2.5 ppm	

VOLTAGE (%)	POWER (VDC)	TEMP (°C)	FREQUENCY (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	3.85	+ 20 (Ref)	817,900,000	154	0.0000189
100 %		- 30	817,900,000	-136	-0.0000167
100 %		- 20	817,900,000	-222	-0.0000272
100 %		- 10	817,900,000	62	0.0000076
100 %		0	817,900,000	36	0.0000044
100 %		+ 10	817,900,000	-175	-0.0000215
100 %		+ 20	817,900,000	193	0.0000237
100 %		+ 30	817,900,000	-68	-0.0000083
100 %		+ 40	817,900,000	57	0.0000070
100 %		+ 50	817,900,000	158	0.0000194
BATT. ENDPOINT	3.45	+ 20	817,900,000	-72	-0.0000088

Table 6-6. LTE Band 26 Frequency Stability Data (Ch. 26697)

Frequency Stability / Temperature Variation

§2.1055, §90.213

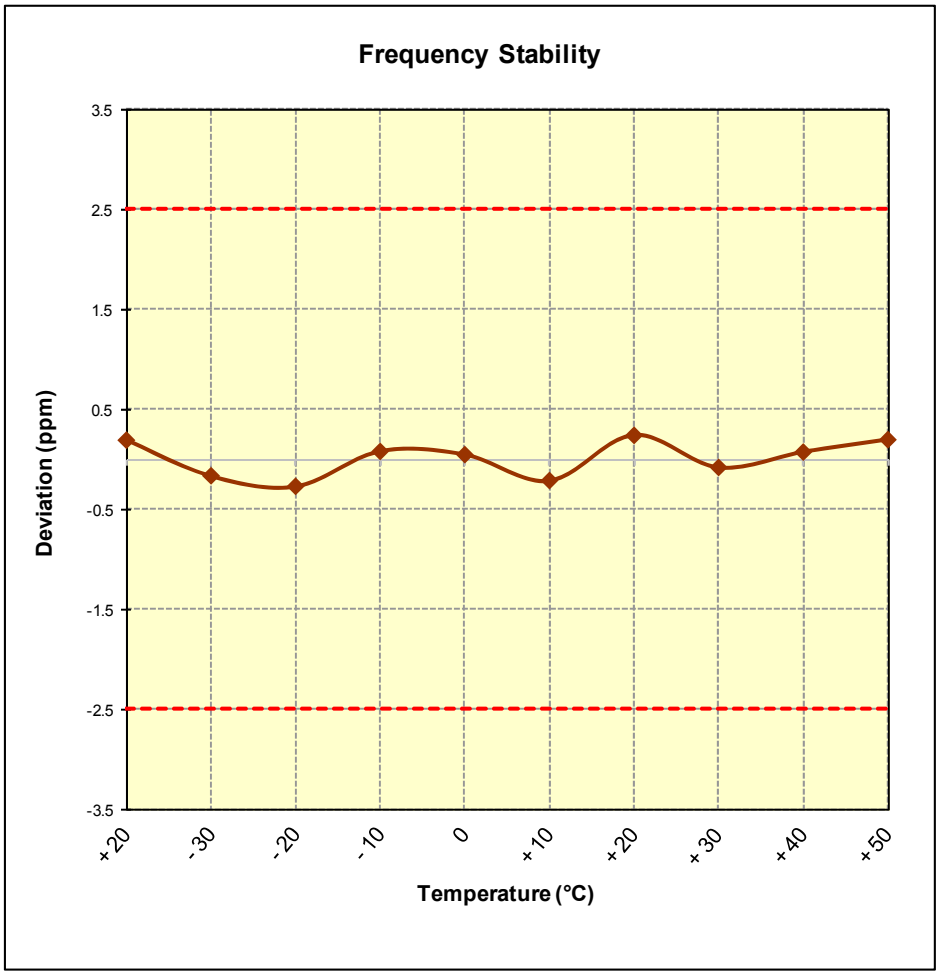
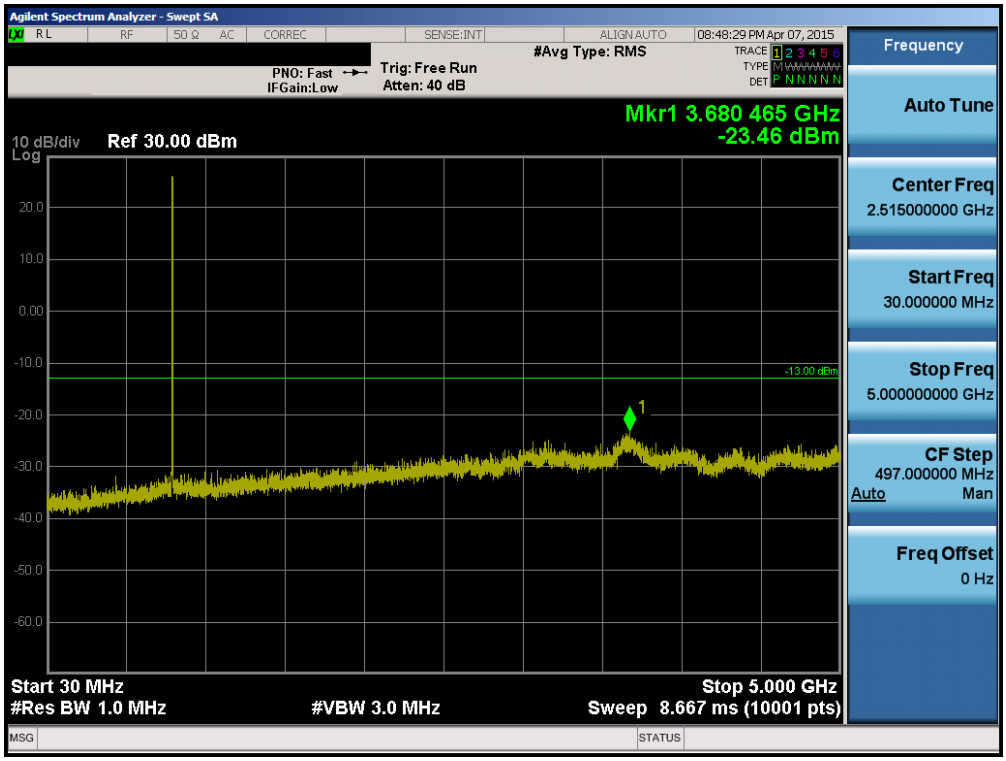
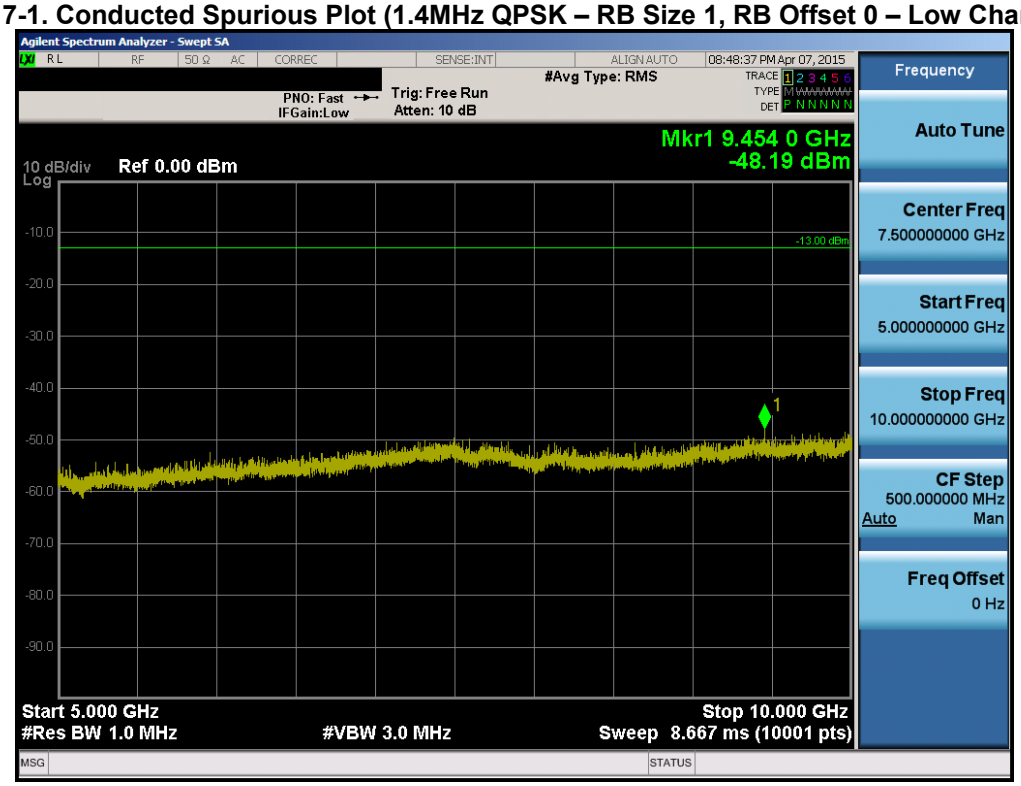


Table 6-7. LTE Band 26 Frequency Stability Data (Ch. 26697)

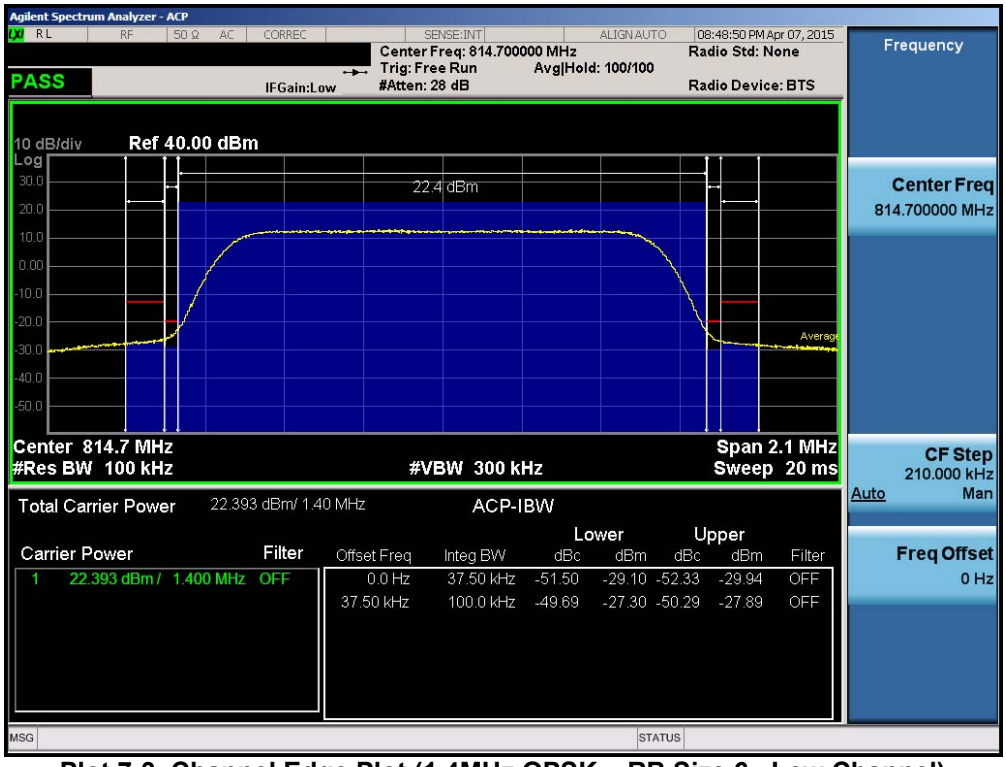
7.0 LTE PLOTS OF EMISSIONS



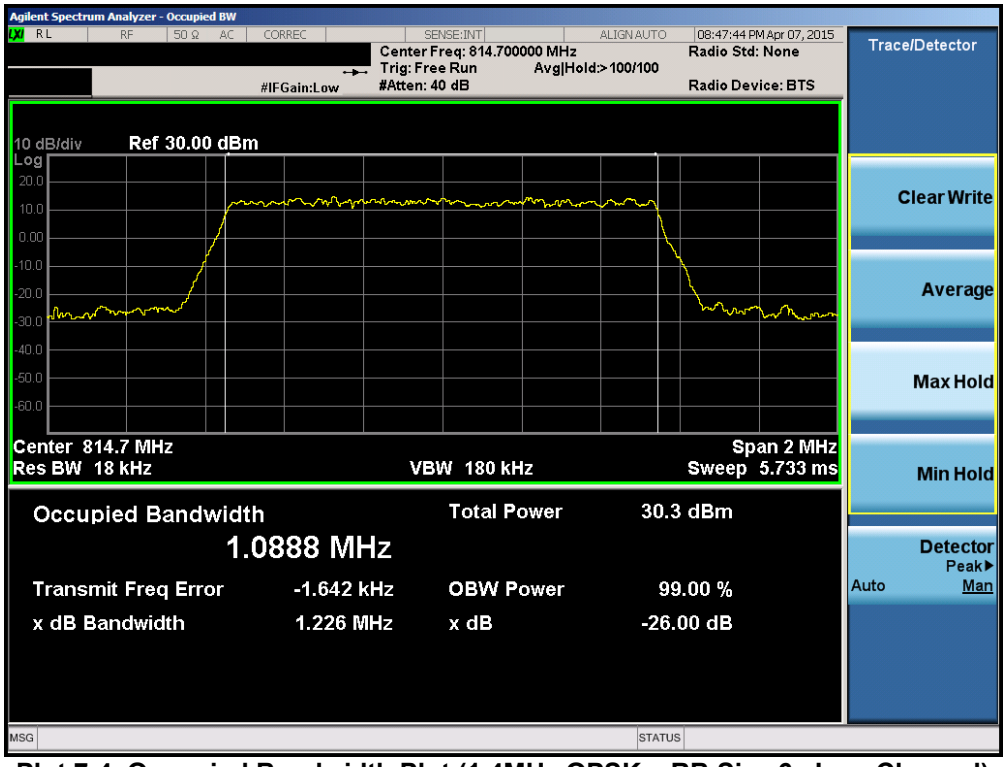
Plot 7-1. Conducted Spurious Plot (1.4MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)



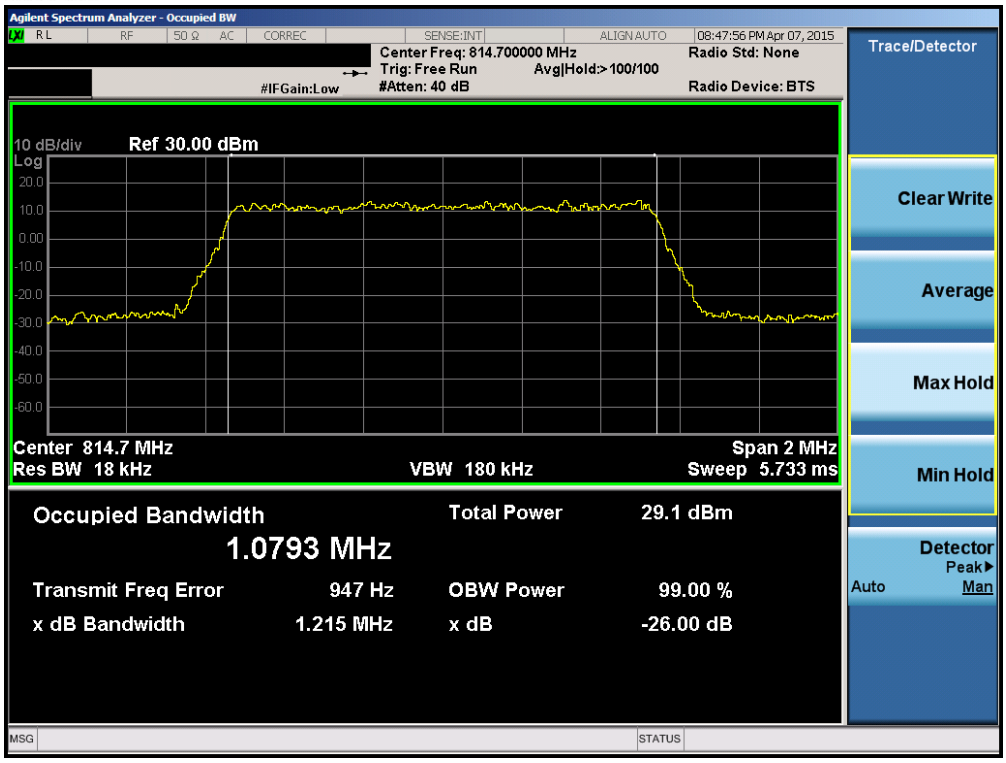
Plot 7-2. Conducted Spurious Plot (1.4MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)



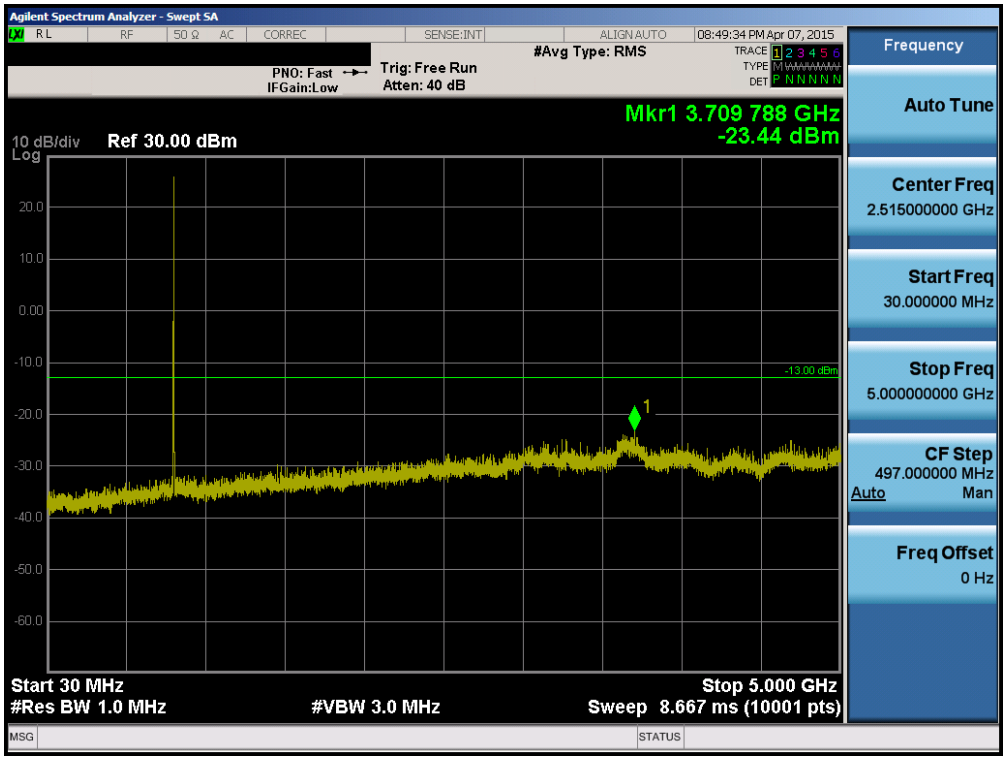
Plot 7-3. Channel Edge Plot (1.4MHz QPSK – RB Size 6– Low Channel)



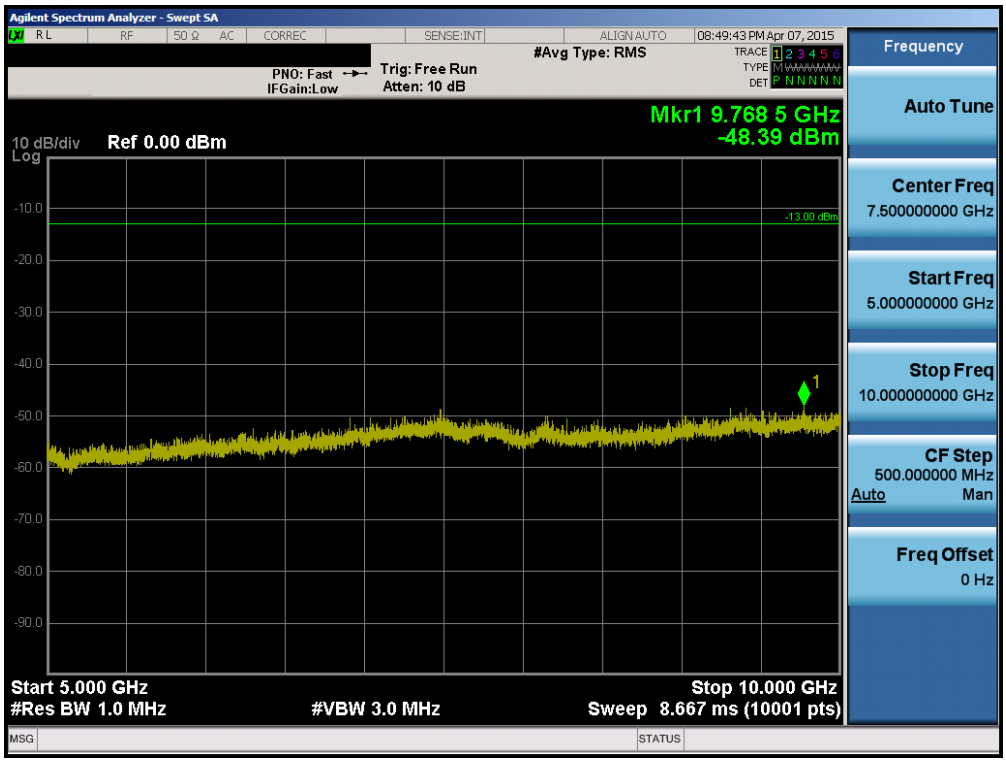
Plot 7-4. Occupied Bandwidth Plot (1.4MHz QPSK – RB Size 6– Low Channel)



Plot 7-5. Occupied Bandwidth Plot (1.4MHz 16-QAM – RB Size 6– Low Channel)

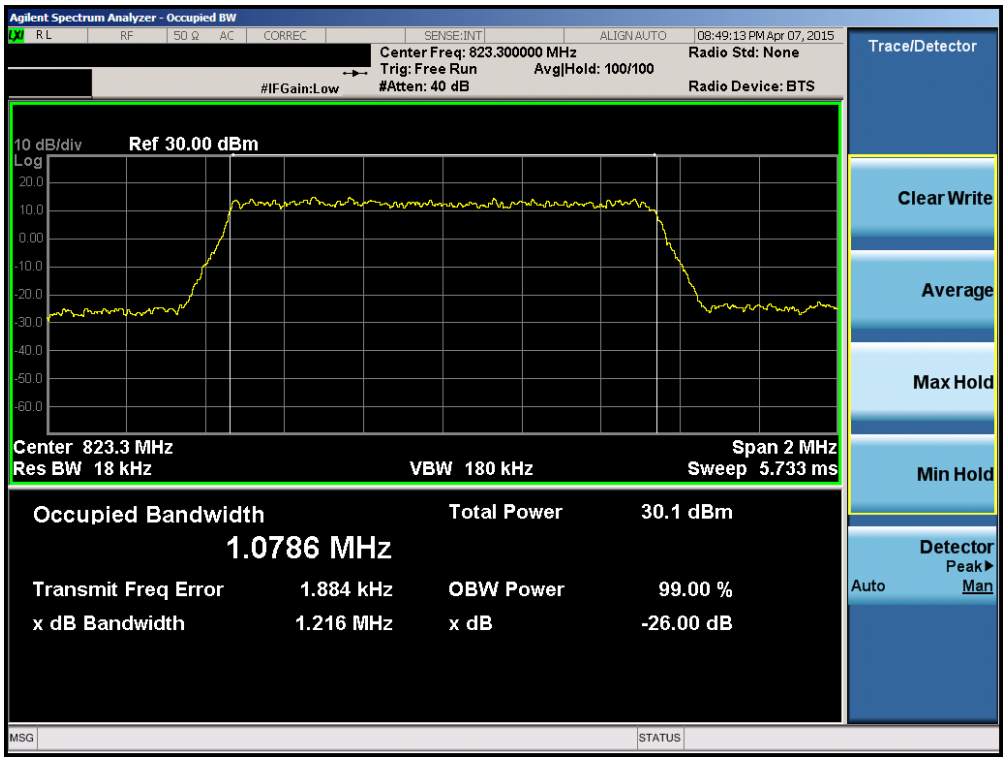


Plot 7-6. Conducted Spurious Plot (1.4MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

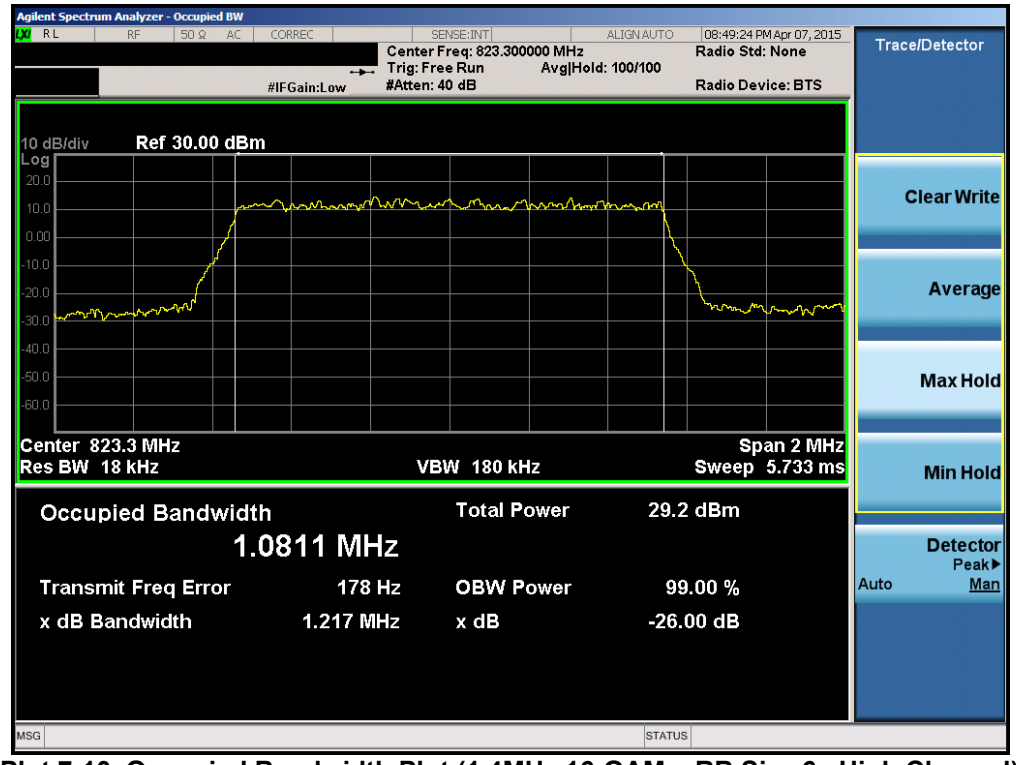


Plot 7-7. Conducted Spurious Plot (1.4MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

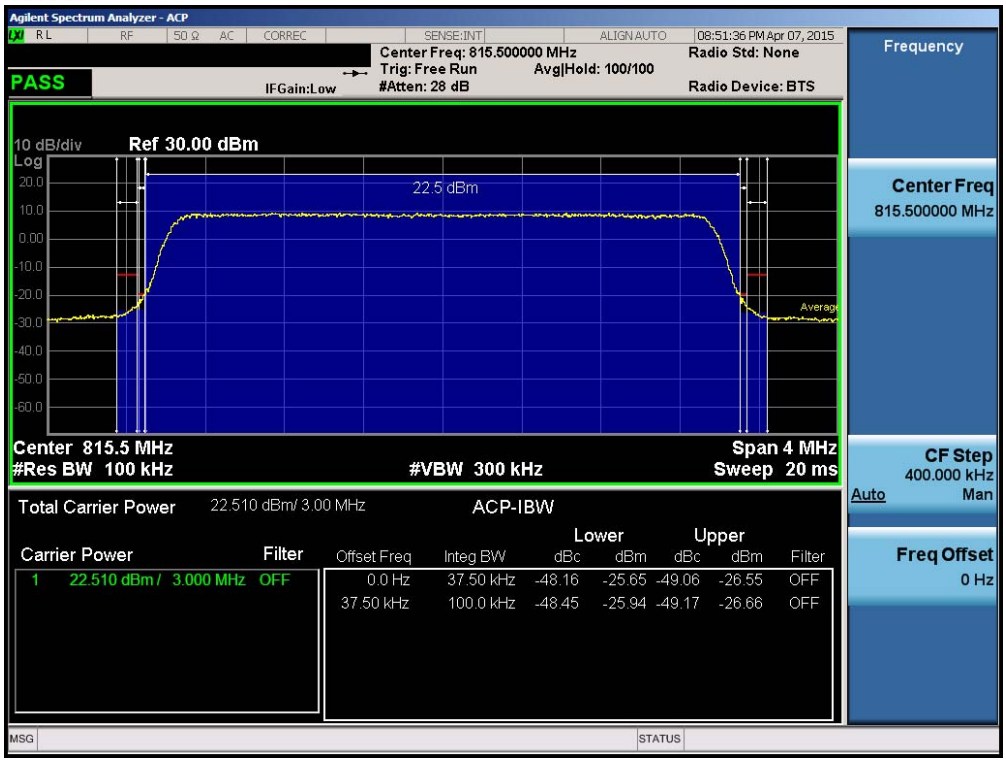
Plot 7-8. Channel Edge Plot (1.4MHz QPSK – RB Size 6 – High Channel)



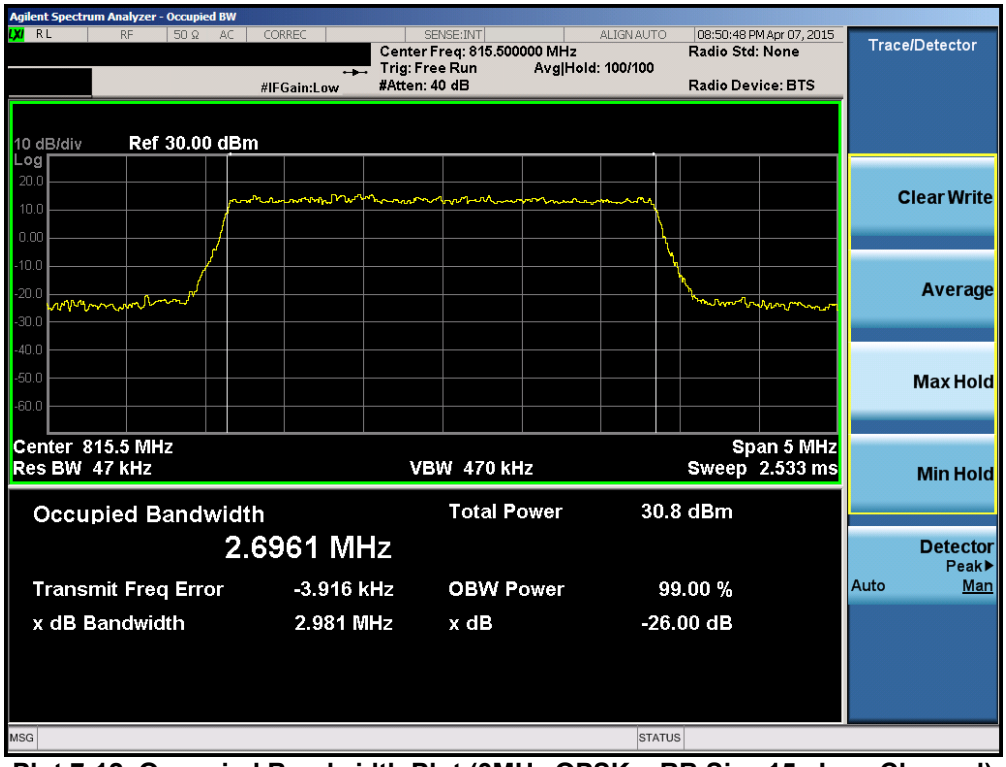
Plot 7-9. Occupied Bandwidth Plot (1.4MHz QPSK – RB Size 6– High Channel)



Plot 7-10. Occupied Bandwidth Plot (1.4MHz 16-QAM – RB Size 6– High Channel)

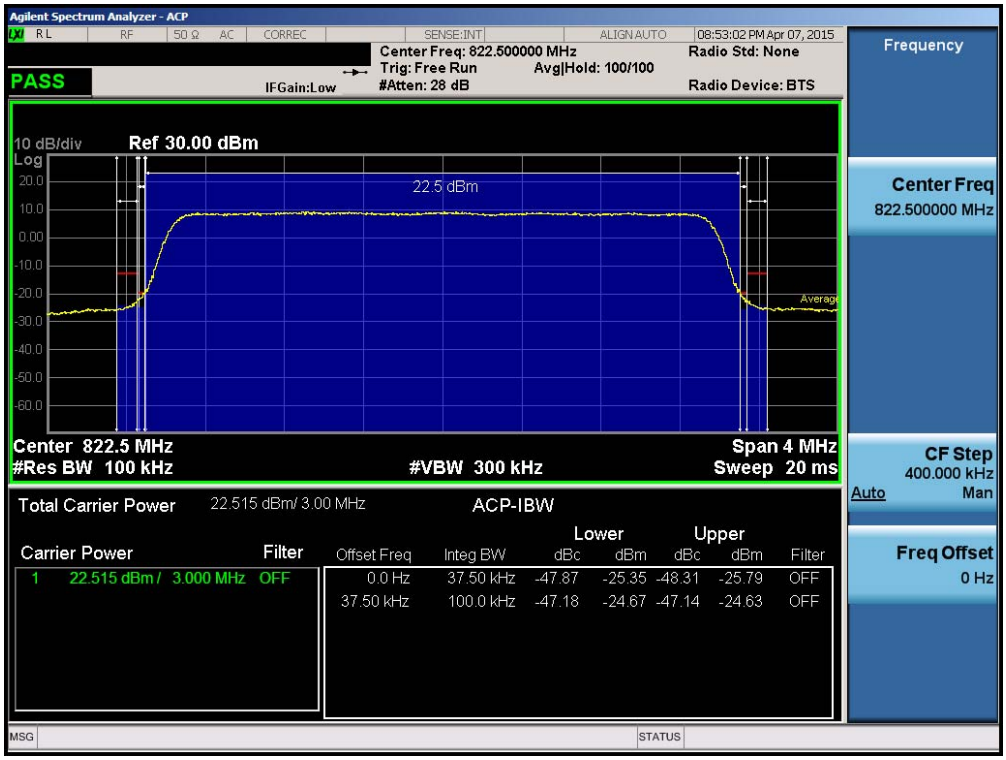


Plot 7-11. Channel Edge Plot (3MHz QPSK – RB Size 15– Low Channel)

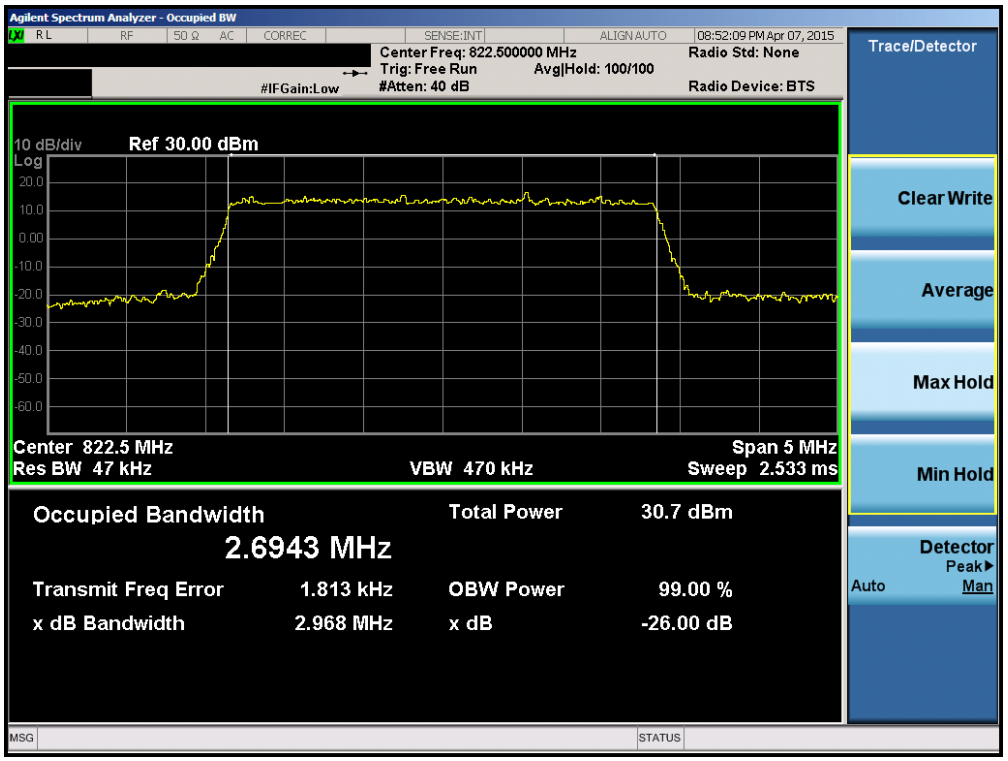


Plot 7-12. Occupied Bandwidth Plot (3MHz QPSK – RB Size 15– Low Channel)

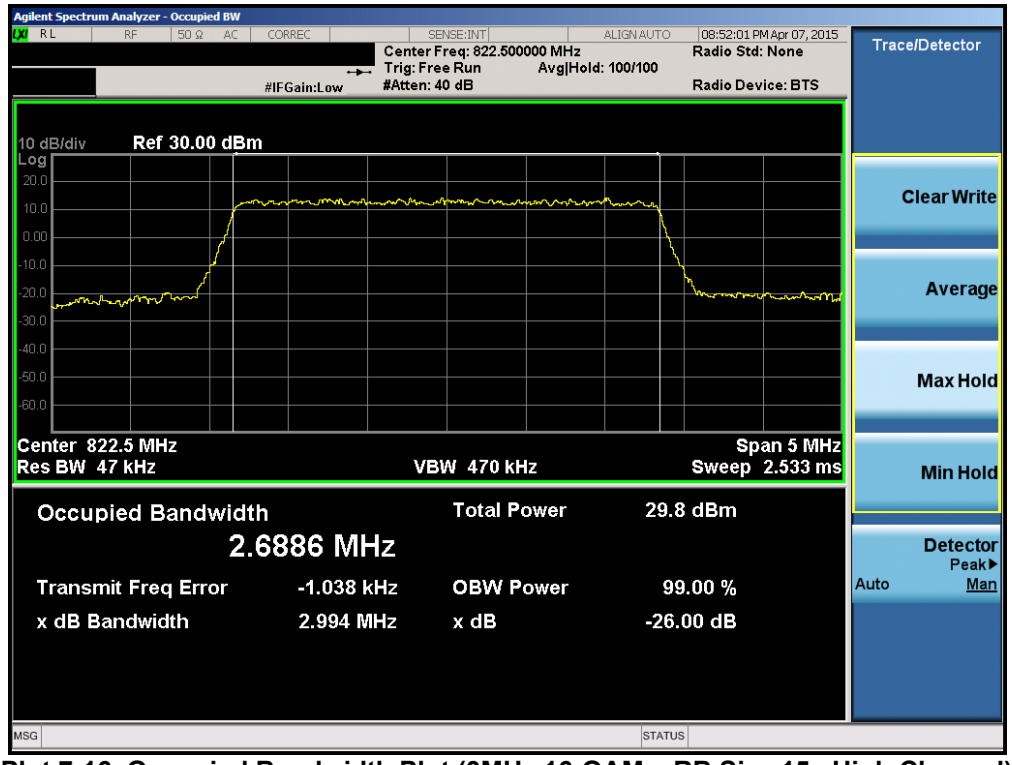
Plot 7-13. Occupied Bandwidth Plot (3MHz 16-QAM – RB Size 15– Low Channel)



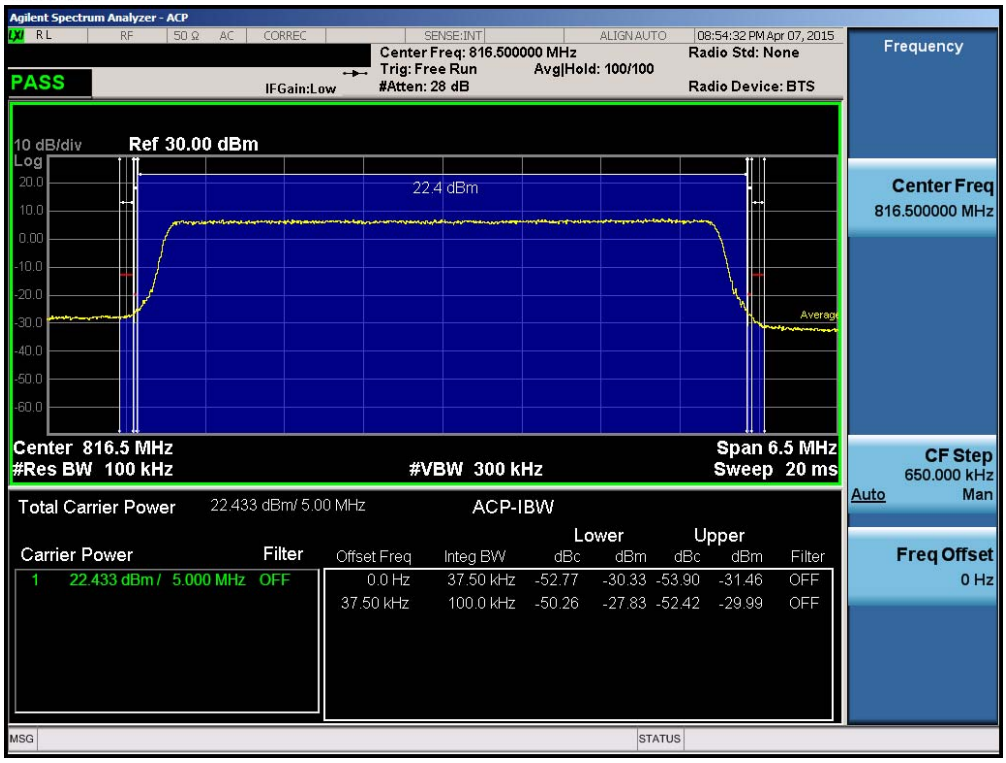
Plot 7-14. Channel Edge Plot (3MHz QPSK – RB Size 15 – High Channel)



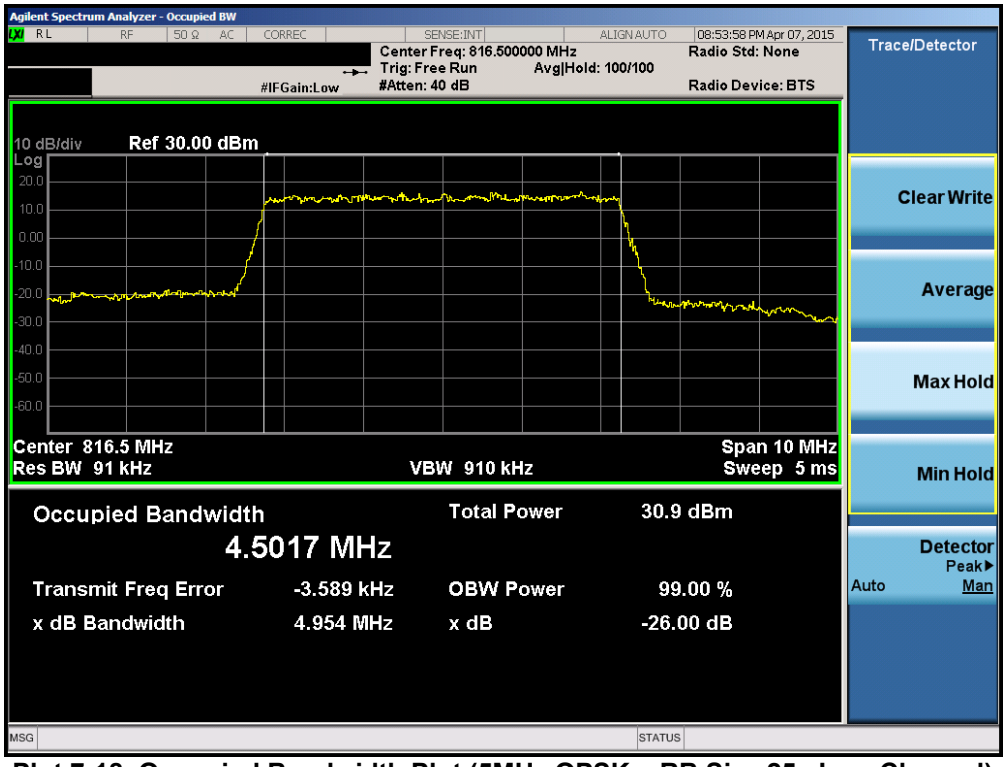
Plot 7-15. Occupied Bandwidth Plot (3MHz QPSK – RB Size 15– High Channel)



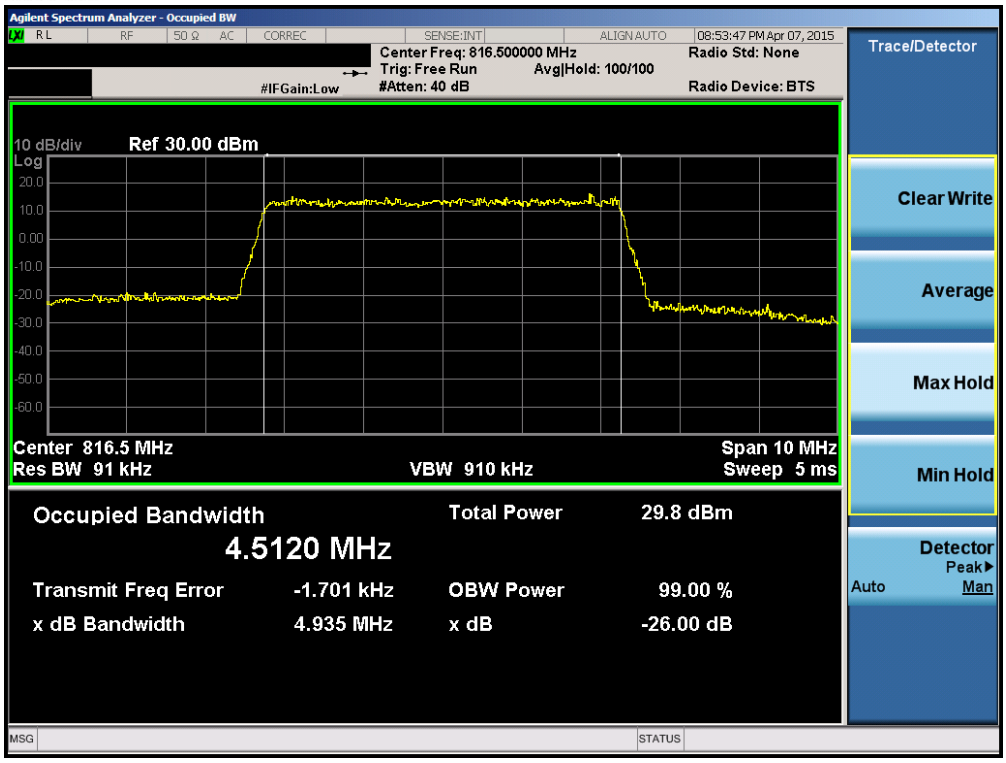
Plot 7-16. Occupied Bandwidth Plot (3MHz 16-QAM – RB Size 15– High Channel)



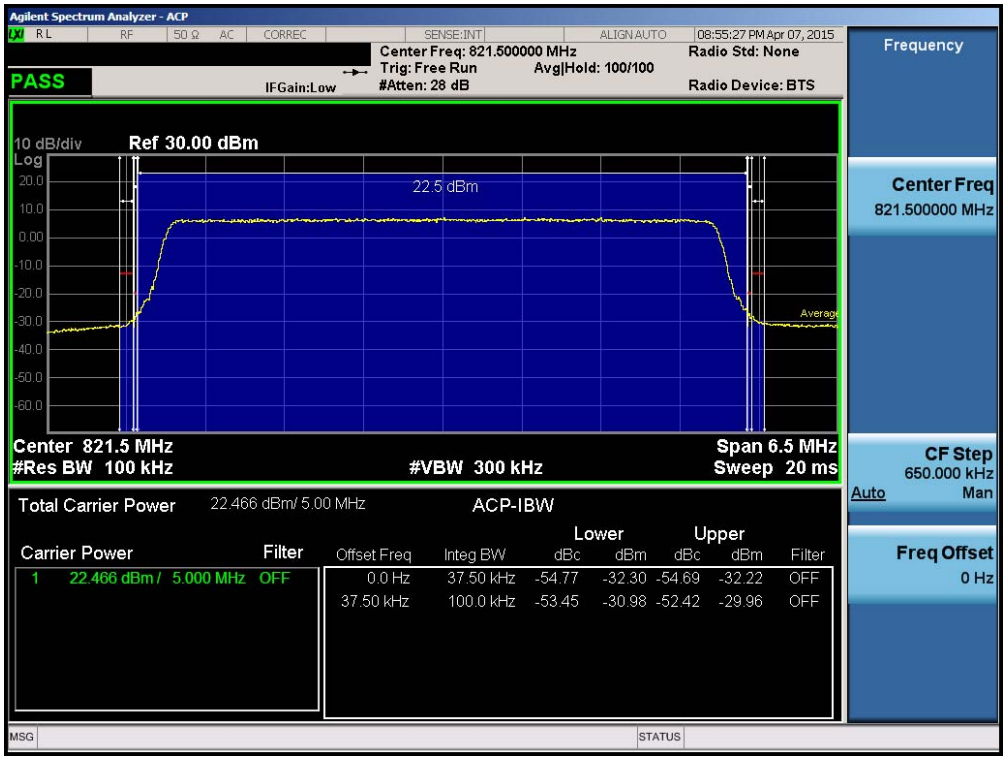
Plot 7-17. Channel Edge Plot (5MHz QPSK – RB Size 25– Low Channel)



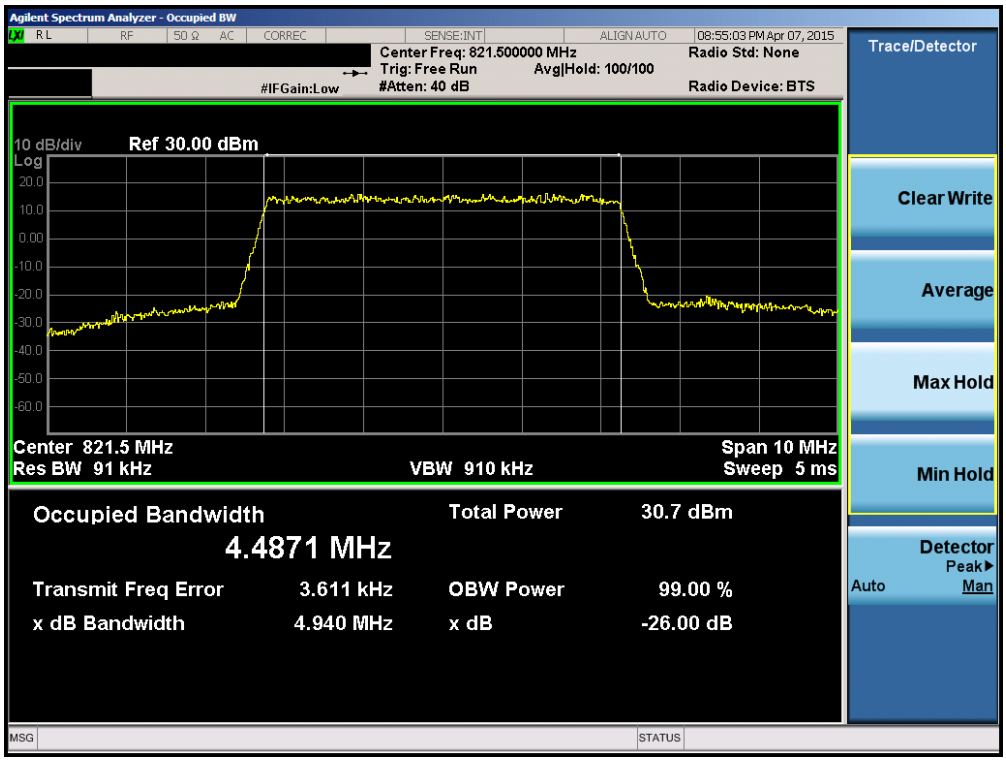
Plot 7-18. Occupied Bandwidth Plot (5MHz QPSK – RB Size 25– Low Channel)



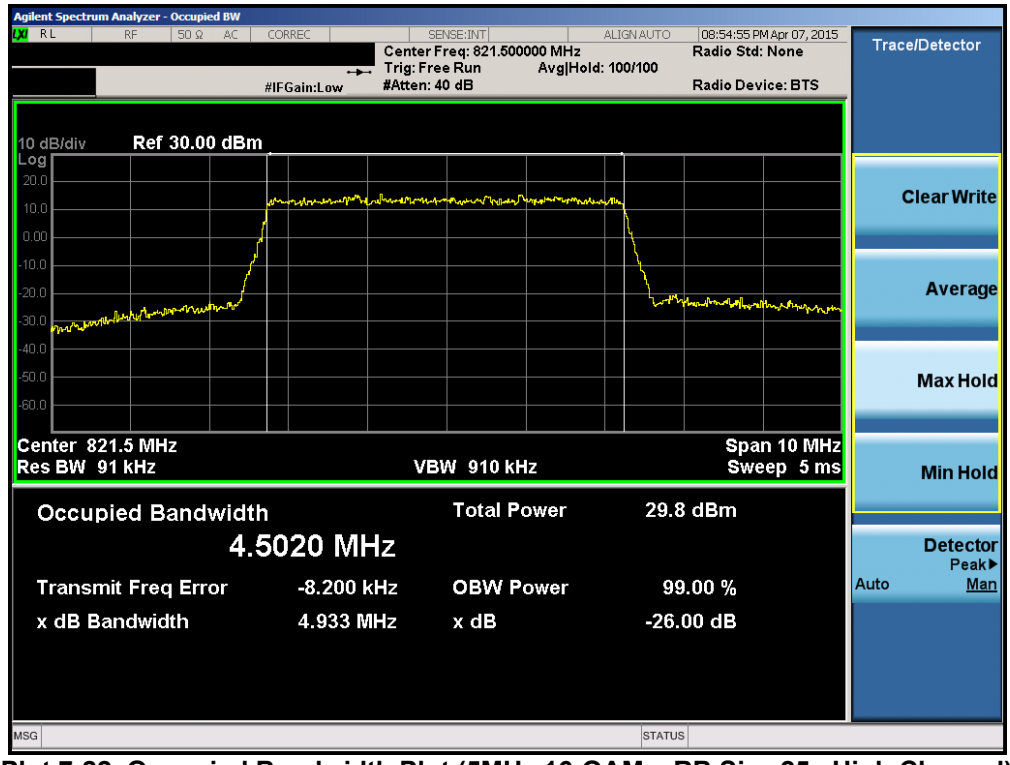
Plot 7-19. Occupied Bandwidth Plot (5MHz 16-QAM – RB Size 25– Low Channel)



Plot 7-20. Channel Edge Plot (5MHz QPSK – RB Size 25 – High Channel)

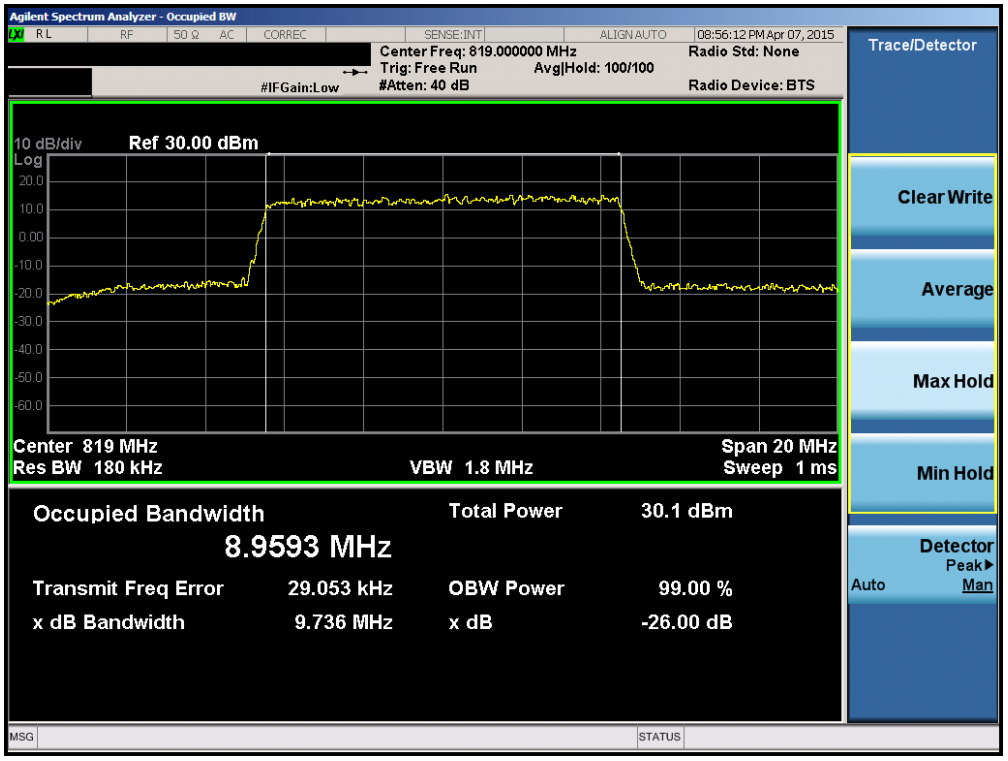


Plot 7-21. Occupied Bandwidth Plot (5MHz QPSK – RB Size 25– High Channel)

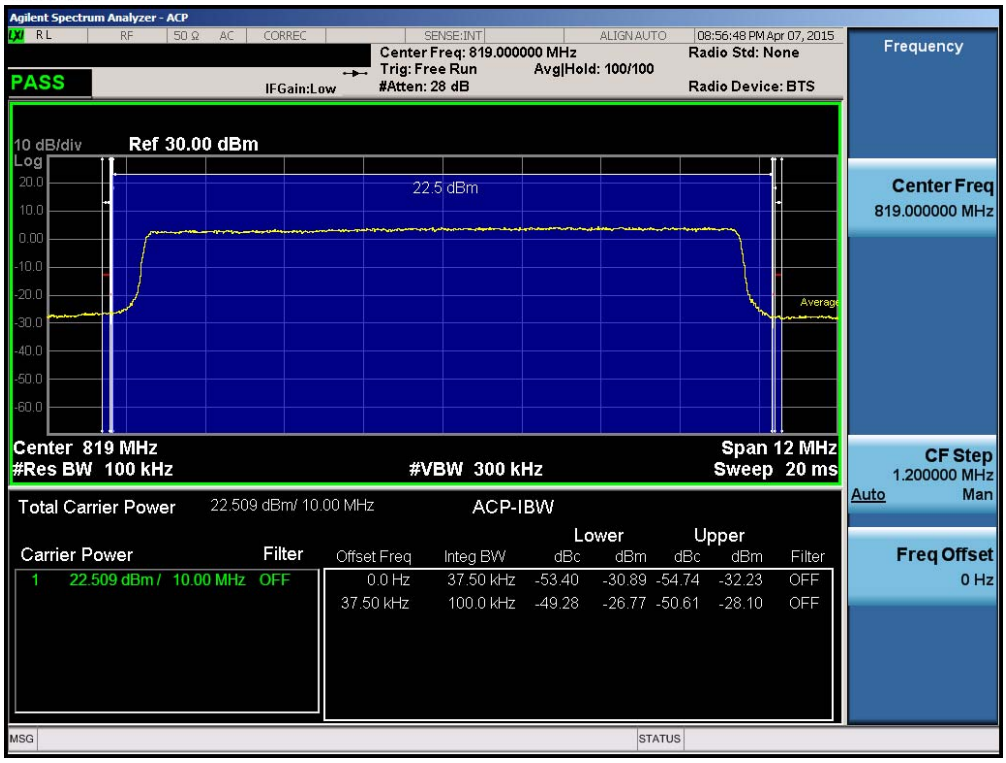


Plot 7-22. Occupied Bandwidth Plot (5MHz 16-QAM – RB Size 25– High Channel)

Plot 7-23. Occupied Bandwidth Plot (10MHz QPSK – RB Size 50)



Plot 7-24. Occupied Bandwidth Plot (10MHz 16-QAM – RB Size 50)



Plot 7-25. Channel Edge Plot (10MHz QPSK – RB Size 50)

8.0 CONCLUSION

The data collected relate only to the item(s) tested and show that the **Samsung Portable Handset FCC ID: A3L404SC** complies with all the requirements of Part 90 of the FCC rules.